Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/617,113	CHOWN, DAVID	
Examiner	Art Unit	

Leslie Pascal

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	OF AD	CUED			
	SEARCHED				
Class	Subclass	Date	Examiner		
398	135-139	11/7/2006	LP		
398	22	6/26/2007	LP		
		<u>,</u>			
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEE SEAR	CH NOTES	2/24/2007	LP

SEAR( (INCLUDING SE	CH NOTES EARCH STRATEGY	<b>(</b> )
	DATE	EXMR
see search notes	11/6/2007	LP
see search notes	6/26/2007	LP